

Notice of References Cited	Application/Control No. 10/810,445	Applicant(s)/Patent Under Reexamination LEHE ET AL.	
	Examiner Victor X. Nguyen	Art Unit 3734	Page 1 of 1

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*	B	US-5,662,703	09-1997	Yurek et al.	623/1.12
*	C	US-6,152,946	11-2000	Broome et al.	606/200
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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